Unit: mm

TOSHIBA Diode Silicon Epitaxial Planar Type

JDV2S27SC

VCO for UHF Band Radio

High Capacitance Ratio: C_{1V}/C_{4V} = 2.9 (typ.)

• Low Series Resistance : r_s = 0.48 ohm (typ.)

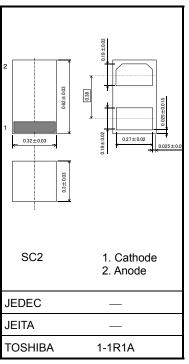
 A two-terminal ultra-small package supports high-density mounting and the downsizing of end products.

Absolute Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Reverse voltage	V_{R}	10	٧
Junction temperature	Tj	150	°C
Storage temperature range	T _{stg}	-55~150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate,



Weight: 0.00017 g (typ.)

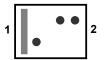
Electrical Characteristics (Ta = 25°C)

etc).

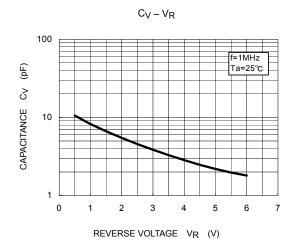
Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Reverse voltage	V_{R}	$I_R = 1 \mu A$	10	_	_	V
Reverse current	I _R	V _R = 5 V	_	_	1	nA
Capacitance	C _{1V}	V _R = 1 V, f = 1 MHz	8	_	8.5	- pF
	C _{4V}	V _R = 4V, f = 1 MHz	2.75	_	2.93	
Capacitance ratio	C _{1V} /C _{4V}	_	2.81	_	3	_
Series resistance	r _S	V _R = 1 V, f = 470 MHz	_	0.48	0.63	Ω

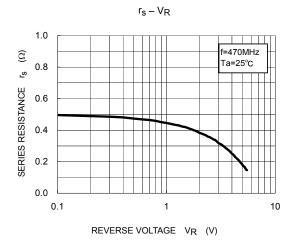
Note: Signal level when capacitance is measured: V_{sig} = 100 mVrms

Marking



1 2007-12-10





2 2007-12-10

RESTRICTIONS ON PRODUCT USE

20070701-EN

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
 In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
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 that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses
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3 2007-12-10